

METAL CONTACT LGA SOCKET

BACKGROUND OF THE INVENTION

[0001] The subject invention relates to a Land Grid Array (LGA) socket and more particularly to a high density socket with precise alignment to an electrical component.

[0002] Various packages or devices exist within the computer industry which require interconnection to a printed circuit board. These devices have lands or balls which are placed on 1.0-mm centerline spacing and below. These devices are profiled with arrays of 50 by 50 and even greater. Given the plurality of lands, their centerline spacing, and given the force applied to each land, this device causes a variety of problems in practice in connection to the printed circuit board.

[0003] Sockets exist within the market for the interconnection of such devices, where the sockets include columns of conductive polymer allowing the interconnection between the devices and the printed circuit boards. However, these devices too can cause some problems. For example, the conductive polymers can creep over time, and after temperature exposure and thermal cycling. Therefore, its elasticity is reduced, and the normal force, which is applied to the contact interface, is also reduced.

[0004] Moreover, as the density of these sockets and interconnects increases, the complexity of maintaining alignment also increases. Many connector sockets attempt to align the contacts with the interconnected components through the housing. As the housings are molded plastic, the tolerance can be such that, the alignment of the contacts is skewed due to the high tolerance of the housing.

[0005] These and other problems are addressed by the present invention.

SUMMARY OF THE INVENTION

[0006] The objects of the invention have been accomplished by providing an LGA interconnect, for interconnection to further electrical components, the LGA interconnect comprising a substrate and a plurality of contact assemblies positioned and retained to the substrate for connection with the electrical components. The interconnect further comprises alignment members projecting from the substrate for aligning the substrate relative to at least one of the electrical components.

[0007] The contact assembly comprises a first contact extending from a first side of the substrate and a second contact extending from a second side of the substrate, the first and second contacts defining an array of contacts. The LGA interconnect further comprises a frame housing surrounding the array of contacts. The alignment members are comprised of pins. The pins extend through the frame housing for registration directly to one of the electrical components. The pins are discrete members attached at diametrically opposite positions of the substrate. The frame housing can laterally float relative to the pins. The frame housing is comprised of first and second frame parts attached to each other. The first and second frame parts are attached at marginal edges of the substrate. One of the frame parts includes frame pins projecting through the substrate, while the other of the frame parts includes alignment apertures for receiving the frame pins in a press-fit manner.

[0008] The frame housing further comprises at least one frame support member extending from side edges of the frame housing across the substrate, for supporting the electrical components above the substrate. The frame housing comprises frame support members having a cruciform configuration extending from opposite side edges of the frame housing and extending across the substrate, for supporting the electrical components above and below the substrate. The substrate is substantially rectangular in configuration and the frame support members define quadrants on both sides of the substrate.

[0009] In another aspect of the invention, an LGA interconnect is profiled for interconnection to further electrical components, and comprises a substrate having an upper surface and a lower surface, marginal side edges, and an array of contact receiving openings therein. A plurality of contact assemblies are positioned and retained in the substrate, with a first contact portion positioned above the upper surface and a second contact positioned below the lower surface. The plurality of contacts define an array of contacts. A frame housing is positioned around a periphery of the substrate. Alignment members project from the substrate for aligning the substrate relative to at least one of the electrical components.

[0010] The alignment members are comprised of pins. The pins extend through the frame housing for registration directly to the electrical component. They are discrete members attached at diametrically opposite positions of the substrate. The frame housing can laterally float relative to the pins. The frame housing is comprised of first and second frame parts attached to each other. The first and second frame parts are attached at marginal edges of the

substrate. One of the frame parts includes frame pins projecting through the substrate, while the other of the frame parts includes alignment apertures for receiving the frame pins.

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BRIEF DESCRIPTION OF THE DRAWINGS

[0012] Figure 1 shows a top perspective view of another embodiment of the LGA interconnect of the present invention;

[0013] Figure 2 shows a lower perspective view of the embodiment of Figure 1;

[0014] Figure 3 shows an exploded view of the various components of the embodiment of Figure 1;

[0015] Figure 4 shows a perspective view of a first frame member;

[0016] Figure 5 shows a lower perspective view of a second frame member;

[0017] Figure 6 shows an enlarged underside perspective view of the cover of the embodiment of Figure 1;

[0018] Figure 7 shows a perspective view of the substrate of the embodiment;

[0019] Figure 8 shows an enlarged view of the area denoted in Figure 7;

[0020] Figure 9 shows a cross-sectional view through lines 9-9 of Figure 8;

[0021] Figure 10 shows a portion of a stamped lead frame showing the contact portion prior to overmolding the insert;

[0022] Figure 11 shows the over-molded insert over the lead frame of Figure 10;

[0023] Figure 12 shows a side view of the insert shown in Figure 11;

[0024] Figure 13 is a cross-sectional view through lines 13-13 of Figure 12;

[0025] Figure 14 is a cross-sectional view through lines 14-14 of Figure 12;

[0026] Figure 15 is a cross-sectional view through the insert of Figure 12, after the swaging process;

[0027] Figure 16 is a view similar to that of Figure 8, showing the pin in the first installed position;

[0028] Figure 17 is a cross-sectional view through lines 17-17 of Figure 16;

[0029] Figure 18 is a view similar to that of Figure 16, showing the pin in the next position;

[0030] Figure 19 is a cross-sectional view similar to that of Figure 17, showing the pin transitioning to the locked position;

[0031] Figure 20 is a cross-sectional view similar to that of Figures 17 and 19, showing the pin in the locked position;

[0032] Figure 21 is a perspective view of the assembled substrate and upper and lower frame members;

[0033] Figure 22 is a view similar to that of Figure 21 from the opposite side thereof;

[0034] Figure 23 is an enlarged view of a portion of the frame and contact members denoted in Figure 22; and

[0035] Figure 24 shows an enlarged view of the central portion of the substrate denoted in Figure 22.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

[0036] The subject invention relates to a Land Grid Array (LGA) interconnect socket and a method of manufacturing the same. When used herein, the term LGA is meant to define many different interconnects. For example, it could be interpreted to mean a chip interconnected to a printed circuit board. However, it can also mean a board to board interconnect. In this application, the invention will be described by way of an interconnect to a chip.

[0037] With respect first to Figures 1-3, the LGA interconnect is shown at 2 and includes a frame housing 4 (Figure 2) comprised of first and second frame members 4A and 4B (Figure 3), a cover 5, and a substrate 6 which carries a plurality of contact assemblies 8. With reference

now to Figure 4, frame housing portion 4A will be described in greater detail.

[0038] Frame housing portion 4A includes frame side wall portions 10A, 12A, 14A, and 16A. Frame housing portion 4A further includes extension ears 18A extending from diametrical corners having pin-receiving apertures 20A, as will be described further herein. At the other diametrical corners, frame housing portion 4A includes edges 22A. Alignment pins 24 extend downwardly from the frame housing 4A and are substantially cylindrical in cross section. Finally, frame support members 26A extend between opposing side edges of the frame housing 4A and is cruciform in configuration having a first member 28A and a second member 30A defining quadrants therebetween.

[0039] With respect now to Figure 5, frame housing portion 4B will be described in greater detail. It should be appreciated that frame housing portion 4B is complementary to frame housing portion 4A and is designed to trap therebetween the substrate member 6. With respect to Figure 5, frame housing portion 4B includes side edge portions 10B, 12B, 14B, and 16B. In a similar manner to frame housing portion 4A, frame housing portion 4B includes extension ears 18B extending from diametrical corners having apertures 20B. The other corners include edges 22B. Frame housing portion 4B also includes frame support member 26B, having support members 28B and 30B. Finally, as shown in Figure 5, frame housing portion 4B includes a plurality of hexagonal openings 32 in an array which matches the array of pins 24 on housing member 4A.

[0040] With respect now to Figure 6, cover 5 will be described in greater detail. As shown in Figure 6, in an

underside perspective view, cover 5 includes side walls 34 and top wall 36 defining an enclosure 38 therein. It should be appreciated that cover 5 is profiled to be received over the combination of frame housing portions 4A, 4B and the substrate 6. Thus, at each corner of cover 5, an extension portion 40 is provided and is profiled to be received over extension ears 18A and 18B. As best shown in Figure 6, these extensions include apertures 42 for alignment purposes with the substrate directly as will be further described herein. In the opposite corners, latch members 46 are provided having latching arms 48, as best shown in Figures 2 and 6, and will also be described in further detail herein.

[0041] With respect now to Figure 7, substrate member 6 will be described. As shown in Figure 7, substrate 6 is substantially rectangular in configuration. In fact, as shown in Figure 7, substrate 6 is substantially square in configuration so as to define four equal quadrants, and as defined by bisecting lines 52, 54. Substrate 6 includes side edges 60, 62, 64, and 66. With respect now to Figure 7, substrate 6 includes extension ears 70 at diametric opposite corners of the substrate 6. With reference now to Figure 8, extension ear 70 is shown in greater detail having an aperture shown generally at 72 having a Figure-8 configuration. Aperture 72 includes an enlarged opening at 74 transitioning into a smaller opening 76 by way of flat transition edges at 78. A latch member 80 is provided extending into opening 76 opposite a stop edge 82. Latch 80 includes a chamfered edge at 84 and a latching edge at 86, as will be described in greater detail.

[0042] As shown in Figure 7, substrate 6 further includes a plurality of apertures 90, whereby the apertures are defined in an array of quadrants, whereby at the

intersection of the quadrants, each of the contacts generally faces the center of the substrate. As shown in Figure 7, each aperture 90 includes end edges 92, side edges 94 and angled side edges 96. These apertures are substantially similar to those described in Applicants co-pending, concurrently filed patent application serial number _____, Attorneys Docket 17992. With respect still to Figure 7, apertures 98 are provided, which are in alignment with cylindrical pins 24, but are larger in diameter than the pins 24. Substrate 6 further includes a side edge 100 at diametrical corners of the substrate 6, as will be described further herein.

[0043] With respect now to Figures 10-14, contact assemblies 108 will be described in greater detail. As shown in Figure 11, contact assembly 108 includes a stamped terminal portion 110 having an overmolded insert member 112 overmolded thereto. As shown in Figure 10, the stamped terminal 110 includes a central portion 114 having an elongate aperture 115, with contact portions 116 and 118 extending from opposite sides thereof defining contact sections 120 and 122. With respect now to Figures 11 and 12, insert 112 is shown molded onto terminal portion 110. Insert 112 includes a shank portion 128, end portions 130, head portion 136, and projecting portion 140. However, in addition, insert 112 includes a slot 144, which as shown in Figures 12 and 13, extends part way into end portions 130. Slot 144 defines opposing surfaces 146 and 148.

[0044] Finally, and with reference again to Figure 8, interconnect 2 includes a locating pin 150 having a cylindrical pin portion 152, an undercut groove 154, and a reduced diameter portion at 156. As shown in Figure 9, at the location of groove 154, the pin includes flat surfaces

at 158 and reduced diameter surfaces at 160. With the details of the various components described, the manufacturing and assembly of the interconnect 2 will now be described.

[0045] The substrate 6 is manufactured in a similar manner to that described above, with the substrate defined with the characteristics shown in Figure 7. While the substrate could be made from many different materials, such as Mylar, ceramic, plastic, or metal, this embodiment utilizes a stainless steel substrate, where the specific characteristics, such as the apertures 90 and the detail of apertures 98 and 72, are defined by an etching process. However, it should be recognized that some embodiments could be provided by a stamping process. In either event, in this embodiment apertures 90 are formed in quadrants about the substrate, as mentioned above along bisecting lines 52, 54.

[0046] With respect now to Figure 10, the terminals are provided by a process to define a lead frame similar to that shown in Figure 10. The contacts are defined by a metal having a spring characteristic, such as a beryllium copper, and is shown as being stamped and formed to define its characteristics. However, it should also be appreciated that an etching process could also be incorporated to accommodate tight tolerances as the contact density increases.

[0047] Insert 112, shown in Figure 11, is now overmolded about the central portion 114 of the contact, whereby elongate aperture 115 is used as a sprue for the molten plastic to ensure a complete molded insert. The aperture 115 also provides for a retention mechanism for the insert longitudinally along the length of the terminal, after the

insert 112 has solidified. The contact assemblies 108 are now inserted in their respective passageways 90, and it should be appreciated that slot 144, as shown in Figures 12 and 13, will conform in an overlapping manner with a respective aperture 90 and receive an edge of the aperture 90 therein. The inserts are now swaged in a manner whereby the plastic insert is deformed to a position shown in Figure 15. The insert 112 laterally shifts to position the edge of the aperture 90 within the slot 144, and with surfaces 142 and swaged projection 180 gripping the opposite edge of the substrate 6. The overmolded insert 112 and the method of swaging is more fully disclosed in Applicants co-pending, concurrently filed patent application serial number _____, Attorneys Docket Number 17992.

[0048] Alignment pins 150 may now be inserted into their fixed position on substrate 6 by moving the alignment pins 150 from the position shown in Figure 8, to the position shown in Figure 16. It should be appreciated that the diameter of pin portion 152 is less than the diameter of aperture 74 and thus, pin 150 can be inserted into the aperture 74, as shown in Figure 16, with groove 154 aligned with edges 78. As shown in the cross-sectional view of Figure 17, at this position, the flat edges 158 can be aligned with edges 78 of aperture 72 and the pin can be moved from the position shown in Figures 16 and 17, to the position shown in Figure 18. With reference now to Figure 19, when the pin 150 is moved to aperture 76, the diameter of radiused surfaces 160 is less than the diameter of aperture 76, and therefore the pin can be rotated in the clockwise sense as viewed in Figure 19, by one-quarter turn, to the position in Figure 20. In this position one flat edge 158 abuts stop edge 82, and the other flat edge 158 is trapped against edge 86 (Figure 8) of latch arm 80. Figure

18 shows how the latch arm 80 extends into the groove 154 of pin 150.

[0049] At this stage, all contact assemblies are inserted in, and the locating pins 150 are fixedly secured to, substrate 6. The frame housing members 4A and 4B may now be positioned with respective apertures 20A, 20B over the locating pins 150, which positions the frame support members 28A, 30A; 28B, 30B (Figures 4 and 5) intermediate the quadrants of contact assemblies, as best shown in Figures 21 and 22. The two frame housing members 4A and 4B are press-fit together, due to the interference fit between cylindrical pins 24 (Figure 4) and their respective receiving apertures 32 (Figure 8) to provide an interference fit between them, as best shown in the exploded view of Figure 23.

[0050] As best shown in Figure 24, the contact assemblies 8 are assembled in quadrants about the support members 28B and 30B to define an array of contacts for interconnection to a further electrical component. It should also be appreciated that the support members 28A, 30A; 28B, 30B act to both rigidify the substrate 6 as well as to provide for a positive stop position for the electrical component to which the LGA interconnect 2 is applied. Said differently, if the LGA interconnect 2 is applied intermediate to two printed circuit boards, the two circuit boards could be assembled to the interconnect 2, such that the two printed circuit boards are drawn together to a position where the circuit boards contact the support members 28A, 30A; 28B, 30B.

[0051] With reference again to Figures 21 and 22, it should be appreciated that the edges 22A overlap their respective edges 22B, thereby defining a latching edge.

With the upper device now positioned against frame housing portion 4A, cover 5 can be positioned over the assembly of the frame housing 4 and substrate 5 and latches 6 (Figure 6) can latch over the overlapping edge 22A, as best shown in Figure 2, while at the same time, cylindrical pin portions 152 (Figure 7) may be received in their receiving apertures 42 (Figure 6) of cover 5. An underside perspective view of the embodiment as assembled is shown in Figure 2, with the remainder of pin 150, and the reduced diameter portions 156 extending from the frame housing portion 4B for further alignment and connection to, a further electrical device.

[0052] Thus, the contact assemblies 8 have enhanced retention to their substrate 6 by way of the slot 144 (Figures 11 and 12) being positioned against an edge of its respective aperture 90 (Figure 15) which provides for a retention of the plastic insert 112 on both sides of the aperture 90, against respective surfaces 94 (Figure 7). Furthermore, the support members 28A, 28B; 30A, 30B allow for proper positioning of an electrical component against the interconnect 2 providing adequate contact force, but preventing overstressing of the contact assemblies. Furthermore, and as best shown in Figure 24, the contacts are arranged in quadrants such that all frictional components of forces cancel each other out, thereby preventing any lateral forces from being transferred to the interconnected component causing degradation of the electrical connection. Finally, as the alignment pins are accurately secured directly to the substrate, the pins can be used to precisely locate the contacts to the electrical component for connection.